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### Introduction

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Two-dimensional (2D) SnS<sub>2</sub> has attracted significant attention as a potential candidate for modern electronics and optoelectronics. However, the in-plane growth of large ultra-thin SnS<sub>2</sub> nanosheets (NSs) still remains a great challenge. In this study, we successfully synthesized in-plane SnS<sub>2</sub> NSs with sizes up to 280  $\mu$ m on SiO<sub>2</sub>/Si substrates *via* Te-assisted CVD. On mixing SnO<sub>2</sub> and Te, SnO<sub>2</sub> reacted with Te to form a Sn–Te eutectic mixture with low melting point, which enhanced the volatilization of the SnO<sub>2</sub> precursor. On increasing the substrate temperature from 500 °C to 600 °C, the shape of the SnS<sub>2</sub> NSs varied from truncated triangle or hexagonal (HEX) to semi-HEX. High temperature enhanced the migration of the SnS<sub>2</sub> adatoms on the substrates and over the edge of the SnS<sub>2</sub> NSs; thus, the size of the SnS<sub>2</sub> NSs increased with temperature. Further discussion indicates that the truncated triangular shape mainly formed for the substrate breaks the intrinsic sixfold symmetry into three-fold symmetry. The systematic investigation will significantly increase our understanding of the synthesis of 2D materials *via* Te-assisted CVD.

In-plane growth of large ultra-thin SnS<sub>2</sub> nanosheets

by tellurium-assisted chemical vapor deposition<sup>†</sup>

Recently, two-dimensional (2D)-layered chalcogenide materials (LCMs), such as MoS<sub>2</sub> and WS<sub>2</sub>, have drawn significant interest due to their unique structures and remarkable properties, which make them promising materials for applications in nanoelectronics.<sup>1-4</sup> SnS<sub>2</sub> has a similar layered structure as MoS<sub>2</sub>, in which the Sn layer is sandwiched between two S layers to form a stable three-layer structure.<sup>5</sup> SnS<sub>2</sub> nanosheets (NSs) have been widely investigated in the fields of photocatalysis and lithium-ion batteries.6 Furthermore, SnS2 is non-toxic, earthabundant, and environmentally friendly; thus, it has an evident future advantage in nanoelectronics and optoelectronics.<sup>7-9</sup> Moreover, SnS<sub>2</sub> possesses a large band gap of  $\sim$ 2.3 eV.<sup>10,11</sup> As is well-known, the large band gap can prominently suppress the source-to-drain tunnelling for short channels, making SnS<sub>2</sub> a promising candidate for field effect transistors and photodetectors.12-15 Achievement of the controllable growth of the 2D SnS<sub>2</sub> NSs is the first step for device applications. Recently, studies on the diverse synthesis methods, property characterizations, and potential applications of 2D SnS2 NSs have rapidly increased.16-18

Chemical vapor deposition (CVD) has been proposed as a successful method to synthesize high-quality single-crystalline LCDs, especially on large 2D materials. Peng *et al.*<sup>19</sup> first fabricated SnS<sub>2</sub> NSs by sulfuration of the seeded SnO<sub>2</sub> on a SiO<sub>2</sub>/ Si substrate, and the size of the NSs was 20–50  $\mu$ m. Meng *et al.*<sup>7</sup> certified a screw-dislocation-driven spiral growth process for the synthesis of SnS<sub>2</sub> NSs on mica, and the average thickness of the NSs was ~100 nm and the size was ~43  $\mu$ m. Then, He *et al.*<sup>12</sup> successfully synthesized SnS<sub>2</sub> NSs of several micrometres on carbon cloth. Recently, Zhai *et al.*<sup>8</sup> have also reported large SnS<sub>2</sub> NSs of size up to 150  $\mu$ m synthesized from SnI<sub>2</sub> and S. Yang *et al.*<sup>20</sup> have used S and Sn to produce SnS<sub>2</sub> NSs ranging from 40 to 70  $\mu$ m.

Although significant efforts have been made to prepare 2D SnS<sub>2</sub>, synthesis of large in-plane ultra-thin SnS<sub>2</sub> still faces great challenges. Recent reports have shown that *via* employing a Sn precursor, such as SnI<sub>2</sub> (ref. 8) or Sn<sup>20</sup> powder, with low melting point, large SnS<sub>2</sub> NSs can be fabricated. However, these SnS<sub>2</sub> NSs touched each other to form a compact morphology<sup>8</sup> and islands were grown on the surface of the vertical SnS<sub>2</sub> NSs.<sup>20</sup> Although the in-plane growth of SnS<sub>2</sub> can be realized using SnO<sub>2</sub> as a precursor,<sup>10,19</sup> high melting point of SnO<sub>2</sub> ( $T_{melt} = 1350 \text{ °C}$ ) always leads to low vapour pressure of SnS<sub>2</sub> in the growth process. These limitations greatly hinder the preparation of large in-plane SnS<sub>2</sub> and thus severely restrict its applications.

Recently, Te-assisted  $\text{CVD}^{21,22}$  has been shown to be effective for relaxing the reaction conditions of the synthesis. Motivated by this, we introduced Te in the sulfuration process of  $\text{SnO}_2$  to improve the vapour pressure of the Sn precursor in our CVD system; this method has the potential to efficiently synthesize large  $\text{SnS}_2$  NSs. By mixing Te with  $\text{SnO}_2$  powder as the precursor, we successfully synthesized large-scale high quality 2D  $\text{SnS}_2$  NSs on  $\text{SiO}_2/\text{Si}$  substrates. Our experiments suggest that  $\text{SnO}_2$ 

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#### Paper

reacted with Te to form a Sn–Te eutectic mixture, such as SnTe, with low melting point, as shown in Fig. S1.† The vapour pressure of Sn was tremendously increased and thus improved its growth efficiency. Furthermore, by controlling the substrate temperature from 500 °C to 600 °C, we found that the shape evolution of the SnS<sub>2</sub> NSs varied from truncated triangle or hexagonal (HEX) to semi-HEX. Moreover, the size increased with the substrate temperature. As a result, large ultra-thin inplane SnS<sub>2</sub> NSs with sizes up to 280  $\mu$ m could be synthesized at 600 °C *via* Te-assisted atmospheric pressure (AP) CVD.

### Experimental

#### Synthesis of the SnS<sub>2</sub> NSs on the SiO<sub>2</sub>/Si substrate

The synthesis strategy for the preparation of SnS<sub>2</sub> NSs is schematically illustrated in Fig. 1a. A horizontal tube furnace with two heating zones was used for the synthesis process. A mixture of SnO<sub>2</sub> powder (purity 99.9%, Alfa Aesar) and Te powder (purity 99.9%, Alfa Aesar) with a mass ratio of 2 : 5 in an alumina boat was loaded into the heating zone I, and cleaned SiO<sub>2</sub>/Si substrates were placed downstream in the heating zone II. Thus, we could precisely and separately control the temperature of the precursor and substrate. S powder (purity 99.5%, Alfa Aesar) was loaded into another alumina boat that was placed upstream outside the tube furnace, which was heated using a heating belt. Prior to the growth process, the SiO<sub>2</sub>/Si substrates ( $\sim 1 \times 1 \text{ cm}^2$ ) with 300 nm thick SiO<sub>2</sub> layer were cleaned by a standard ultrasonic process in acetone, isopropyl alcohol, and deionized water for 30 min in sequence, followed by drying with nitrogen  $(N_2)$  gas. Then, the tube was pumped down to 1 Pa to remove the air and then flushed with highpurity argon gas (Ar) several times and filled with Ar to achieve the AP. First, the two heating zones were heated to 850 °C (I) and 500-600 °C (II), respectively. Then, the S powder was heated

to  $\sim$ 180 °C, determined using a K type thermocouple. The growth process was then sustained for 20 min using 20 sccm Ar as the carrier gas. Finally, the furnace was naturally cooled down to room temperature.

#### Characterization

The fundamental structural and componential properties were comprehensively investigated using optical microscopy (OM, Nikon), scanning electron microscopy (SEM, FEI NANOSEM 450), energy dispersive X-ray spectroscopy (EDX, Oxford Instrument) attached to SEM, atomic force microscopy (AFM, Bruker Dimension Icon) and Raman spectroscopy (Renishaw inVia). Photoluminescence (PL) spectroscopy (Horiba Jobin Yvon, LabRAM Aramis) was performed using a laser excitation of 325 nm. The morphologies of SnS<sub>2</sub> were characterized using OM, SEM, and AFM. The thickness of the as-grown samples was obtained using AFM. Raman spectroscopy was conducted using a laser excitation of 488 nm. EDX was used to characterize the composition of the products.

### **Results and discussion**

After the reaction, the  $SnS_2$  NSs were formed on the substrates. Fig. 1b and c show the typical OM and SEM images of the final  $SnS_2$  NS on the  $SiO_2/Si$  substrate grown at 600 °C in the heating zone II. The sizes of the ultra-thin  $SnS_2$  NS were up to 280  $\mu$ m and the thickness was about 40 nm, as measured using AFM and shown in the upper-right corner of Fig. 1c. Peng *et al.*<sup>19</sup> obtained 50  $\mu$ m  $SnS_2$  NSs using  $SnO_2$  as the Sn precursor. The results show that the high growth efficiency of  $SnS_2$  NSs was manifested by Te-assisted CVD. To clarify the role of Te during the growth process of the  $SnS_2$  NSs, we performed two independent experiments. First, we vaporized  $SnO_2$  at 850 °C in the



Fig. 1 (a) A schematic of the experimental setup, (b) the OM image of the as-grown  $SnS_2 NS$  at ~600 °C, and (c) the corresponding SEM image of the  $SnS_2 NSs$ ; the upper-right corner: AFM image of red dashed box of  $SnS_2 NSs$ .

heating zone I without Te or S. After being carried by 20 sccm Ar for about 20 min, the weight of SnO<sub>2</sub> barely changed. Moreover, no obvious structures were found on the substrate loaded into the heating zone II whose temperature was kept at 600 °C. Second, a mixture of SnO<sub>2</sub> and Te was vaporized under the same growth conditions, and the SnTe nanoblocks were obtained on the substrates at 600 °C. The SEM image of SnTe and its corresponding EDX data are shown in Fig. S2.† These two independent experiments suggest a possible growth mechanism: Te melts at a relatively low temperature in the mixture of Te and SnO<sub>2</sub> powders, and a small fraction of SnO<sub>2</sub> powders dissolves in Te to form a Sn-Te eutectic mixture, such as SnTe, with low melting temperature. Therefore, the amount of the Sn precursor was enhanced via the Te-assisted CVD process, which was similar to that obtained after employing the SnI<sub>2</sub> powder as the Sn precursor.8 In a sulfur-rich environment, Te (originating from the reaction  $SnTe + 2S(gas) = SnS_2 + Te(gas)$  leaves the reaction product and is carried away by the Ar flow to the downstream. Thus, the growth efficiency of the SnS<sub>2</sub> NSs was attributed to the low melting point of the Sn-Te eutectic mixture via the addition of Te to the SnO<sub>2</sub> powder, which enhanced the vapour pressure of the Sn precursors in the CVD system.

It is generally believed that the effect of the substrate temperature is a key issue for the synthetic control of the 2D LCM. To illustrate the effect of substrate temperature on the growth of the SnS<sub>2</sub> NSs, we further adjusted the substrate temperature and investigated the morphology of the SnS<sub>2</sub> NSs at various temperatures. Fig. 2 shows the SEM images of the SnS<sub>2</sub> NSs at software temperatures for  $^{\circ}C$  and 600  $^{\circ}C$ . Fig. 2d-f show the enlarged SEM images of the SnS<sub>2</sub> NSs indicated by the red circle in Fig. 2a-c. In our experiments, mostly large flat semi-HEX-shaped SnS<sub>2</sub> NSs were obtained at  $\sim$ 600  $^{\circ}C$ , as shown in Fig. 2c. From the SEM images shown in Fig. 2d-f, we found that

the shape of the  $SnS_2$  NS showed obvious variation from truncated triangular or HEX to semi-HEX, and the size of the  $SnS_2$ NSs increased from 3 µm to 280 µm. Thus, the dominating shape of the NSs could be controlled by adjusting the temperature, and the size of the  $SnS_2$  NSs increased with temperature from several micrometres to hundreds of micrometres.

To confirm the crystallinity and composition of the NSs investigated via SEM, as shown in Fig. 2, we further used Raman spectroscopy and EDX to characterize them. Accordingly, Fig. 3 shows the Raman and EDX spectroscopy spectra of the corresponding SnS<sub>2</sub> NSs shown in Fig. 2d-f. For the SnS<sub>2</sub> crystals, two characteristic Raman peaks were assigned as the  $E_g$  (~205 cm  $^{-1})$  mode and the  $A_{1\mathrm{g}}$  mode (~313 cm  $^{-1}).$  As can be seen from Fig. 3a, the truncated triangular SnS<sub>2</sub> NS gown at 500 °C display two main peaks at  $\sim 205 \text{ cm}^{-1}$  and  $\sim 313 \text{ cm}^{-1}$ , which correspond to the  $E_g$  and  $A_{1g}$  phonon modes of  $SnS_2$ , respectively. On increasing the temperature to 550 °C, the Eg peak at  $\sim 205 \text{ cm}^{-1}$  becomes weaker and still appears in the magnification spectrum, as shown in Fig. 3b. Furthermore, as shown in Fig. 3c, the intense Raman peak of the semi-HEX SnS<sub>2</sub> at 313.4  $cm^{-1}$  was assigned to the  $A_{1g}$  mode, and no  $E_g$  mode could be found, even in the magnified image. This has been demonstrated in a number of studies  $^{8,10,11}$  that the  $E_{\rm g}$  peak disappears due to reduction in the number of scattering centers available for in-plane scattering when the thickness of the SnS<sub>2</sub> NSs is decreased down to the nanometre scale. Raman spectroscopy could confirm that these semi-HEX SnS2 NSs were indeed ultrathin crystals. During the process of obtaining the Raman spectra, as shown in Fig. 3a-c, we did not observe the Raman peaks at 474, 632, or 774 cm<sup>-1</sup> associated with SnO<sub>2</sub>.<sup>20</sup> This implies the complete reaction of the SnO<sub>2</sub> and S powders, and the negligible chemical reaction between SnS<sub>2</sub> and the SiO<sub>2</sub> substrate. The Eg peak vanished in the Raman spectrum of the



Fig. 2 SEM images of the various shapes of  $SnS_2$  NSs grown at different temperatures: (a) 500 °C, (b) 550 °C, and (c) 600 °C. The corresponding enlarged SEM images at specified temperature are indicated by the red box (d, e, and f).



Fig. 3 The Raman and EDX spectroscopy spectra of various shapes of  $SnS_2 NSs$ . (a, b, and c) The Raman spectrum of truncated triangular, HEX, and semi-HEX NSs in (Fig. 2d-f); (d, e, and f) the corresponding EDX spectra.

semi-HEX SnS $_2$  NSs, which demonstrated that ultra-thin SnS $_2$  NSs were obtained at 600  $^\circ C.$ 

Furthermore, EDX spectroscopy was employed to explore the composition of the truncated triangular shape  $SnS_2$  NSs, as shown in Fig. 3d. The Sn : S atomic ratio of the NSs was 1 : 2.026, which was very close to 1 : 2. The HEX and semi-HEX NSs were characterized in the same way. As is evident from their respective EDX spectra displayed in Fig. 3e and f, the atomic ratios close to 1 : 2 agree well with their expected stoichiometric composition. Moreover, in the EDX spectra without the Te signal, it was observed that the addition of Te did not leave any detectable residues in the grown  $SnS_2$  samples.

From the abovementioned discussion, it was concluded that the size of SnS<sub>2</sub> increased with the substrate temperature. It is of great value to understand the evolution mechanism of the SnS<sub>2</sub> NSs with temperature, which may help to controllably synthesize 2D LCMs in the future. As schematically described in Fig. 4a, the growth reaction actually includes three processes: (1) the diffusion of  $SnS_2$  vapor adsorbed onto the substrate, (2) the migration of the  $SnS_2$  adatoms, and (3) the desorption of excess adsorbed SnS<sub>2</sub>. Herein, we divided the migration of the SnS<sub>2</sub> adatoms into three cases: M1 was the migration on the substrate surface, M2 was the migration on the surface of the SnS<sub>2</sub> NSs, and M3 was the migration over the step edge of the SnS<sub>2</sub> NSs. Based on abovementioned discussion, it can be concluded that introduction of Te powder into the SnO<sub>2</sub> powder can greatly lower the original melting point of SnO<sub>2</sub>, allowing a large amount of Sn precursor to volatilize, and the diffusion of the SnS<sub>2</sub> vapor adsorbed onto the substrates increases. As a result, we could obtain large SnS2 NSs and the diffusion flux of SnS<sub>2</sub> was enhanced. If the supply flux of SnS<sub>2</sub> adatoms remains unchanged, the lower temperature of the substrate limits the desorption process of excess adsorbed SnS<sub>2</sub>, and more nucleation SnS<sub>2</sub> sites are formed. Upon increasing the substrate

temperature, the desorption of excess adsorbed  $SnS_2$  became active, and then, the small  $SnS_2$  flakes were easy to vaporize from the substrate and diffusion was enhanced. The decrease in the NSs density with temperature can be related with the number of nucleation sites. A very obvious tendency could be found in which the NSs size increased with the decrease in the NS density from 500 °C to 600 °C, as shown in Fig. 2a–c.

The desorption of excess adsorbed  $SnS_2$  with temperature decreased the density of the  $SnS_2$  NSs. The migration of the adatoms is another important process in the growth reaction. The temperature-dependent migration coefficient *D* of the



Fig. 4 (a) A schematic of the dynamics behaviour in the growth process, M1: migration on the substrates surface, M2: the migration on the surface of the  $SnS_2$  NSs, and M3: the migration over the step of the  $SnS_2$  NSs. (b) The SEM image of the as-grown truncated triangle  $SnS_2$  NSs grown at 550 °C. (c) The SEM image of the overlapped  $SnS_2$  crystal grown at 500 °C.

$$D \propto e^{-E_{\rm m}/kT} \tag{1}$$

where k is the Boltzmann constant and T is the substrate temperature.<sup>22,23</sup>  $E_{\rm m}$  is the energy required for the adatoms to move from one site to another. According to eqn (1), the D value increases with the temperature of the substrates. These migrations are related to the interaction of the SnS<sub>2</sub> adatoms with the substrate (M1), the interaction of the  $SnS_2$  adatoms with the  $SnS_2 NS(M2)$ , and the interaction of the  $SnS_2$  adatoms with the edges of the SnS<sub>2</sub> NS(M3). More specifically, the growth rate of the SnS<sub>2</sub> NSs depends on the flux of the SnS<sub>2</sub> adatoms towards the growth sites via M1 and M2. Higher temperatures increase the migration on the substrate, and then, the SnS<sub>2</sub> NSs grow larger, as shown in Fig. 2d-f. Upon increasing the temperature, the migration of the adatoms becomes faster at the substrates and the adatoms tend to migrate and adhere to the highly activated growth direction that is energetically favorable.<sup>26,27</sup> High temperature increases the migration on the substrates surface, and subsequently, more adatoms diffuse to the growth sites (at the edge of NSs), resulting in the increased size of the NSs.

Because the  $E_{\rm m}$  may linearly increase with the number of dangling bonds,<sup>22</sup> we provided a qualitative comparison between the migration energies of the three types of migration. The atoms at a step edge have fewer nearest neighbours; hence, these atoms have more dangling bonds. If the adatoms on the SnS<sub>2</sub> surface transfer from the upper layer to the lower layer or substrate over the step edge, there will be a high step-edge barrier.20 When an adatom adsorbs on the surface of the NSs and moves towards a step edge, this potential barrier will hinder the migration over the step edge of the SnS<sub>2</sub> NSs and repel the adatom diffusion away from the step edge. Eventually, a new layer grows larger on the former layer and the thickness of the NSs increases. More and more adatoms adsorb on the NS surface, and as a result, the new layer grows up to the same size as the next layer. Thus, the SnS<sub>2</sub> NSs grow in a layer-by-layer mode. Higher temperature increases the migration over the step edge of the SnS<sub>2</sub> NSs, and more adatoms on the NS surface will skip over the step edge to the substrates; therefore, the size of the NSs increases.

Based on the abovementioned discussion, we could suggest that the temperature increases the migrations of the  $SnS_2$  adatoms such as the migrations on the substrate and over the step edge of the NSs. As a result, the size of the  $SnS_2$  NSs increases with the substrate temperature. When the growth temperature was gradually increased, the adatoms diffusion increased. Thus, non-equilibrium shaped NSs may be formed at different growth temperatures. The size of the as-grown NSs would augment with an increase in the growth temperature.

In the low-temperature regimes (500 °C and 550 °C), the shape of the  $SnS_2$  NSs holds six step edges and an angle between any two adjacent step edges of ~120°, as shown in Fig. 2d and (e). There are a number of mechanisms that illustrate the

formation of NSs: growth temperature,<sup>24</sup> step edge barrier,<sup>20</sup> and substrate.<sup>25</sup> In the case of  $\text{SnSe}_2$ ,<sup>24</sup> high temperature enhanced the vapour pressure of Se, and then, the amount of Se decreased with temperature; thus, the shape transformed from truncated triangular to HEX. However, at higher temperature (550 °C), we also found HEX shape  $\text{SnS}_2$  NSs (Fig. 2e) and truncated triangular shape  $\text{SnS}_2$  with different lengths, as shown in Fig. 4b. Thus, the effect of temperature on the amount of S vapour could be ignored for the low melting temperature of the S powder and both shapes appeared at the same temperature.

The inequality in the edge lengths of the islands on  $SnS_2$  (ref. 20) was found in the cooling process and could be explained by the step edge barrier. A normal  $\gamma$ -plot was used to quantify the ratio of the step edge energies such as those of the SnS<sub>2</sub> islands.<sup>20</sup> Following a similar way, a line was drawn from the centre of an SnS<sub>2</sub> NS and perpendicular to a short step edge A (or long step edge, B), as shown in Fig. 4b. The ratios of  $\gamma_{\rm B}/\gamma_{\rm A}$ , as shown in Fig. 4b, were 0.76, 0.73, and 0.78. In the same way, we calculated the ratios of  $\gamma_{\rm B}/\gamma_{\rm A}$ , as shown in Fig. 2a, to be 0.82, 0.83, and 0.87. Only some of the ratios are close to the ratio of 0.88-0.93 observed in the SnS2 islands.20 Moreover, stacking of the NSs with different angles was observed in our samples at 500 °C, which was also observed in the SnSe<sub>2</sub> crystals synthesized via a spiral growth mode in the CVD process (Fig. 4c).<sup>25</sup> This implies the step edge barrier that prevents the adatoms on the upper smaller NSs from reaching the lower larger NSs. This is consistent with the observation that the migration over the step edge of the SnS<sub>2</sub> NSs is limited at lower temperature. As shown in Fig. 4c, the smaller crystals tend to form truncated triangular crystals, whereas SnSe<sub>2</sub> prefer triangular crystals.<sup>25</sup> The ratios of  $\gamma_{\rm B}/\gamma_{\rm A}$  for the smaller crystals, as shown in Fig. 4c, are 0.7, 0.73, and 0.74.

By calculating the ratios of  $\gamma_{\rm B}/\gamma_{\rm A}$  for different truncated triangular shape SnS<sub>2</sub> NSs, we found that these ratios were different from 0.7-0.87, which were different from those reported in the previous studies.20 However, it was confirmed that the longer step edge B had a slower growth rate. According to the kinetic Wulff criterion, any growing crystals tend to have the slowest growth faces.26 It has been established that Mo zigzag edges and S zigzag edges are the most energetically favoured edge structures in MoS<sub>2</sub>,<sup>27</sup> which constructs a hexagonal shape with six edges. In the presence of a substrate, the two sides of the SnSe<sub>2</sub> zigzag edges are no longer identical.<sup>25</sup> The potential breaking of symmetry can be achieved via changing either the edge energy or chemical reaction rate. As is known, SnS2 has a structure similar to that of MoS<sub>2</sub> and SnSe<sub>2</sub>. It should follow a similar principle that an HEX SnS<sub>2</sub> NS has six identical edges and these edges can be either Sn zigzag (Sn-zz) edges or S zigzag (S-zz) edges. They attributed this to a difference in the step edge energies.20 As the edges have the same growth rates of the Sn-zz and Sn-zz edges, they tend to form HEX shapes under equilibrium conditions, as shown in Fig. 2e. The unequal step edge lengths imply that the six edges have unequal growth rates to form the truncated triangle shape. From the abovementioned discussion, we found that the temperature and step energy ratio were not the key issue to form truncated triangle SnS<sub>2</sub>. The substrate that breaks the intrinsic six-fold symmetry into threefold symmetry manifests truncated triangular  $\mathrm{SnS}_2$  for the chemical reaction.

AFM was utilized to identify the thickness of the as-grown  $SnS_2$  NSs at 600 °C. The AFM images, as displayed in Fig. 5a and b, elucidate that the thickness of the as-grown  $SnS_2$  NSs was  $\sim$ 7.9 nm and  $\sim$ 12.7 nm, respectively. Each layer of  $SnS_2$  comprised three atomic planes covalently bonded in the sequence of S–Sn–S, and the layer interactions depended on the

weak van der Waals forces. Taking a theoretic monolayer thickness of ~0.6 nm into consideration, the thickness of the NSs was ~13, and ~21 layers. According to the AFM images, the average roughness of the SnS<sub>2</sub> surface was about 0.3 nm, which implied the high crystallinity of the products. Therefore, we fabricated ultra-thin and high crystallinity SnS<sub>2</sub> NSs, which have immense applications in electronic and optoelectronic devices.



Fig. 5 (a and b) The AFM images of the synthesized  $SnS_2 NSs$ ; scale bar: 5  $\mu$ m. (c) The SEM image of an ultra-thin  $SnS_2 NSs$ . (d and e) The Sn and S element mapping in the red rectangle region of the NSs. (f) The PL spectroscopy of the  $SnS_2 NSs$  measured at atmospheric pressure.

To further elucidate the elemental distribution of the sample, we presented the EDX mapping and PL spectroscopy spectra of the SnS<sub>2</sub> NSs grown at 600 °C, as shown in Fig. 5c. The signals of the Sn and S elements almost originate from our sample, and a uniform distribution of Sn and S elements was revealed in the selected area, as shown in Fig. 5d-f. Fig. 5f shows the PL spectrum obtained from the SnS<sub>2</sub> crystals, and a prominent peak at  $\sim$ 533 nm was observed. The band gap calculated from the PL spectrum is 2.33 eV, which is similar to that previously reported.<sup>28</sup> The measured PL peak at  $\sim$ 533 nm was generated due to the recombination of electron-hole pairs, which was demonstrated in a number of studies, such as SnS<sub>2</sub> nanoparticles made using wet chemistry methods that showed a PL peak at 550 nm,<sup>29</sup> the PL peak of the SnS<sub>2</sub> NSs appeared between 540 and 562 nm,30 mechanically exfoliated SnS2 flakes presented a band gap of ~2.23 eV,12 and SnS2 nanocrystals made from chemical vapor transport displayed a band gap of  $\sim$ 2.25 eV.<sup>31</sup> There is a relatively lower or even negligible peak at  $\sim$ 467 nm. We could not provide a clear explanation for this PL peak. According to a previous study,32 we speculated that it may be due to the radiative recombination of the excitonic absorption generated electrons, which were located at the higher excited energy levels. Herein, we found that the PL intensity was extremely weak due to the indirect band gap of SnS2, which was confirmed by the results found for SnS<sub>2</sub> synthesized by other group.28 All these characterizations demonstrate that the sample is a high-quality single-crystalline SnS<sub>2</sub> material.

### Conclusions

In summary, we presented an effective CVD growth technique to fabricate large ultra-thin SnS<sub>2</sub> NSs on SiO<sub>2</sub>/Si substrates using Te assistance. The high temperature and Te-assistance increases the evaporation pressure of SnS<sub>2</sub>, and as a result, we could obtain large in-plane SnS<sub>2</sub> NSs. Upon increasing the temperature of the substrate, the shape of the SnS<sub>2</sub> NSs changes from truncated triangle or HEX to semi-HEX. Further discussion showed that the truncated triangular shape resulted from the substrate that broke the intrinsic six-fold symmetry into three-fold symmetry. Among all the growth temperatures studied herein, large high-crystalline SnS<sub>2</sub> NSs with sizes up to 280  $\mu$ m were obtained on the SiO<sub>2</sub>/Si substrates at ~600 °C. The  $SnS_2$  NSs are indirect band gap (~2.23 eV) semiconductors and can be thinned to 7.9 nm. The results show that the Te-assisted CVD process is a powerful tool to design and synthesize other 2D LCMs. A fundamental understanding of the effect of temperature can pave the way towards the controllable growth of the 2D LCMs.

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